

Search Notes

Application/Control No.

10/620,840

Examiner

Shin-Lin Chen

Applicant(s)/Patent under
Reexamination

DUFF, KAREN

Art Unit

1632

SEARCHED

Class	Subclass	Date	Examiner
800	13		
800	18		
536	23.5		
536	24.1		
435	455	3/29/2006	<i>SL</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST, STN, Medline, Caplus, Biosis, Scisearch, Lifesci, parent reviewed and updated, inventor name search.	3/29/2006	<i>SL</i>